

**Search Notes**

Application/Control No.

09/929,736

Examiner

David M. Naff

Applicant(s)/Patent under  
Reexamination

SCHUELLER ET AL

Art Unit

1657

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
To date See parent	12/11/08	sn